2018年11月19日 星期 首页 | 期刊介绍 | 编委会 | 投稿指南 | 期刊订阅 | 联系我们 | 留言板 | English

光学精密工程 » 2015, Vol. 23 » Issue (9): 2482-2489 DOI: 10.3788/OPE.20152309.2482

现代应用光学

最新目录| 下期目录| 过刊浏览| 高级检索

◀ 前一篇 后一篇 >>

光学系统弥散斑参数的测试

李坤, 陈永权, 赵建科, 段亚轩, 李巧玲, 潘亮, 龙江波, 张海洋

中国科学院 西安光学精密机械研究所, 陕西 西安 710119

## Measurement of defocused spot parameters of optical system

LI Kun, CHEN Yong-quan, ZHAO Jian-ke, DUAN Ya-xuan, LI Qiao-ling, PAN Liang, LONG Jiang-bo, ZHANG Hai-yang

Xi'an Institute of Optics and Precision Mechanics, Chinese Academy of Sciences, Xi'an 710119, China

参考文献 相关文章 (15)

全文: PDF (1514 KB) RICH HTML NEW

输出: BibTeX | EndNote (RIS)

摘要采用CCD显微成像系统对光学系统弥散斑参数进行定量测量,并设计了弥散斑参数的评价算法。首先,给出了弥散斑参数的定义,分析 了弥散斑所形成的能量等高线构成的闭合的连通区域,对占总能量80%的区域计算其弥散斑直径。然后,对该区域的边界点进行椭圆拟合, 得到弥散斑圆度。提出的方法通过对光学系统在像平面所成的星点像的能量分布的分析,在弥散斑圆度测试中引入了椭圆拟合,减少了CCD 噪声和测试环境中的杂光等随机因素对测试结果的影响,提高了测试结果的置信度。实验结果显示:弥散斑直径测试重复性为0.18 μm,弥 散斑圆度测试重复性为1.65%。提出的方法实现了弥散斑参数的定量测试,满足航天项目中光学系统成像质量控制要求。

**关键词**: 光学系统,弥散斑参数,CCD显微测量系统,能量等高线,区域填充,椭圆拟合

**Abstract**: Defocused spot parameters of an optical system were measured by a testing system with CCD microscopic imaging quantitatively, and an evaluating method for the defocused spot parameters was designed. Firstly, the definitions of the defocused spot parameters including the diameter and the roundness were given. The connected region shaped by the energy contour of the defocused spots was analyzed, and the diameter equal to the area which is 80% of the total energy of the defocused spots was calculated. Then, the boundary of the region was fitted as an ellipse and the roundness of defocused spot was obtained. The method introduces the ellipse fit into the defocused spot roundness measurement through analysis of the energy distribution of star point image on image plane, so that the effects of CCD noise and stray light in test environment on the measuring results are reduced and the confidence of the test results is improved. The experimental results show that the repeatability of the diameter is 0.18  $\mu m$  and that of the roundness is 1.65%. The method meets the needs of the optical systems in space projects for the imaging quality control.

Key words: optical system defocused spot parameter CCD microscopic system energy contour region filling

ellipse fitting

收稿日期: 2015-04-02

中图分类号: TB96 TH703

基金资助:神光Ⅲ大科学工程资助项目(No.091Z512B0A)

作者简介: 李坤(1983-),男,山西朔州人,工程师,2009年于四川大学获得硕士学位,主要从事光学检测技术及图像处理方面的研究。 Email:wllk-19821118@163.com;陈永权(1979-),男,山西忻州人,高级工程师,2006年于四川大学获得硕士学位,主要从事激光光束参数 标定和质量评价方面的研究。E-mail:cyq@opt.ac.cn

## 引用本文:

李坤, 陈永权, 赵建科, 段亚轩, 李巧玲, 潘亮, 龙江波, 张海洋. 光学系统弥散斑参数的测试[J]. 光学精密工程, 2015, 23(9): 2482-2489. LI Kun, CHEN Yong-quan, ZHAO Jian-ke, DUAN Ya-xuan, LI Qiao-ling, PAN Liang, LONG Jiang-bo, ZHANG Hai-yang. Measurement of defocused spot parameters of optical system. Editorial Office of Optics and Precision Engineering, 2015, 23(9): 2482-2489.

## 链接本文:

http://www.eope.net/CN/10.3788/OPE.20152309.2482 http://www.eope.net/CN/Y2015/V23/I9/2482

## 访问总数:6353307

版权所有 © 2012 《光学精密工程》编辑部 地址: 长春市东南湖大路3888号 邮编: 130033 E-mail: gxjmgc@sina.com 本系统由北京玛格泰克科技发展有限公司设计开发



服务

- 把本文推荐给朋友
- ▶ 加入我的书架
- 加入引用管理器
- ▶ E-mail Alert
- **▶** RSS

作者相关文章

- ▶李坤
- ▶ 陈永权
- 赵建科
- ▶段亚轩 ▶ 李巧玲
- ▶ 潘亮
- ▶ 龙江波
- ▶ 张海洋